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| APPLICATION NO. | FILING DATE | FIRST NAMED INVENTOR | ATTORNEY DOCKET NO. | CONFIRMATION NO. | |
|--|-----------------------|----------------------|--|-----------------------------|--|
| 10/774,682 | 02/09/2004 | Thomas Rueckes | 112020.129 US2 (Nan-6) | 112020.129 US2 (Nan-6) 9428 | |
| 23483 75 | 23483 7590 04/19/2005 | | EXAMINER | | |
| WILMER CUTLER PICKERING HALE AND DORR LLP 60 STATE STREET BOSTON, MA 02109 | | | COLEMAN, WILLIAM D | | |
| | | | A S TO LIN | | |
| | | | ART UNIT | PAPER NUMBER | |
| | | | 2823 | | |
| | | | DATE MAILED: 04/19/2005 | | |

Please find below and/or attached an Office communication concerning this application or proceeding.

| <u> </u> | | | | | | |
|---|---|---|--|--|--|--|
| | | Application No. | Applicant(s) | | | |
| Office Action Summary | | 10/774,682 | RUECKES ET AL. | | | |
| | | Examiner | Art Unit | | | |
| | | W. David Coleman | 2823 | | | |
| Period fo | The MAILING DATE of this communication ap or Reply | pears on the cover sheet with the | correspondence address | | | |
| A SH THE - Exte after - If the - If NC - Failu Any | ORTENED STATUTORY PERIOD FOR REPL MAILING DATE OF THIS COMMUNICATION. nsions of time may be available under the provisions of 37 CFR 1. SIX (6) MONTHS from the mailing date of this communication. period for reply specified above is less than thirty (30) days, a rep period for reply is specified above, the maximum statutory period are to reply within the set or extended period for reply will, by statute reply received by the Office later than three months after the mailing patent term adjustment. See 37 CFR 1.704(b). | 136(a). In no event, however, may a reply be ly within the statutory minimum of thirty (30) d will apply and will expire SIX (6) MONTHS fro e, cause the application to become ABANDON | timely filed ays will be considered timely. In the mailing date of this communication. NED (35 U.S.C. § 133). | | | |
| Status | | | | | | |
| 1)⊠ | Responsive to communication(s) filed on 09 F | February 2004. | | | | |
| , | This action is FINAL . 2b) \boxtimes This action is non-final. | | | | | |
| 3)□ | Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213. | | | | | |
| Disposit | ion of Claims | | | | | |
| 5)□ 6)⊠ 7)□ | Claim(s) 1-15 is/are pending in the application 4a) Of the above claim(s) is/are withdra Claim(s) is/are allowed. Claim(s) 1-15 is/are rejected. Claim(s) is/are objected to. Claim(s) are subject to restriction and/or | wn from consideration. | | | | |
| Applicat | ion Papers | | | | | |
| 10) | The specification is objected to by the Examina The drawing(s) filed on is/are: a) acc Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct The oath or declaration is objected to by the Examination. | cepted or b) objected to by the drawing(s) be held in abeyance. Setion is required if the drawing(s) is a | See 37 CFR 1.85(a). Objected to. See 37 CFR 1.121(d). | | | |
| Priority (| under 35 U.S.C. § 119 | | | | | |
| 12)□ a) | Acknowledgment is made of a claim for foreign All b) Some * c) None of: 1. Certified copies of the priority documen 2. Certified copies of the priority documen 3. Copies of the certified copies of the priority documen application from the International Burea See the attached detailed Office action for a list | ts have been received. ts have been received in Applica prity documents have been recei au (PCT Rule 17.2(a)). | ation No ived in this National Stage | | | |
| 2) Notice 3) Infor | ot (s) the of References Cited (PTO-892) the of Draftsperson's Patent Drawing Review (PTO-948) the of Draftsperson's Patent (s) (PTO-1449 or PTO/SB/08 the No(s)/Mail Date 02/04. | 4) Interview Summa Paper No(s)/Mail 5) Notice of Informa 6) Other: | | | | |

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DETAILED ACTION

Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 2. Claims 1, 2,4,5, 6, 7, 9, 10, 11, 12, 13, 14 and 15 are rejected under 35 U.S.C. 102(b) as being anticipated by Rueckes et al., "Carbon Nanotube-Based Nonvolatile Random Access Memory for Molecular Computing", SCIENCE Magazine, July 7, 2000, vol. 289, pp 94-97.

 Rueckes discloses a semiconductor device as claimed. See FIGS. 1-4, where Rueckes teaches the claimed limitations.

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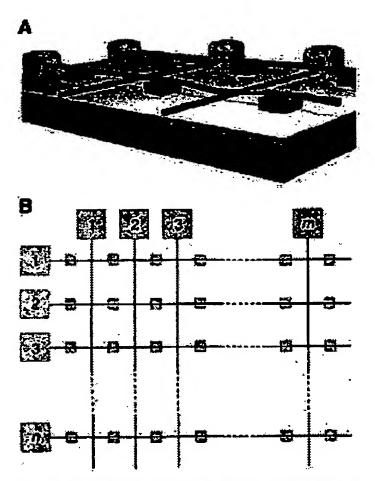


Fig. 1. Suspended nanotube device architecture. (A) Three-dimensional view of a suspended crossbar array showing four junctions with two elements in the ON (contact) state and two elements in the OFF (separated) state. The substrate consists of a conducting layer [e.g., highly doped silicon (dark gray)) that terminates in a thin dielectric layer [e.g., SiO, (light gray)]. The lower nanotubes are supported directly on the dielectric film, whereas the upper nanotubes are suspended by periodic inorganic or organic supports (gray blocks). Each nanotube is contacted by a metal electrode (yellow blocks). (B) Top view of an n by m device array. The nanotubes in this view are represented by black crossing lines, and the support blocks for the suspended SWNTs are indicated by light gray squares. The electrodes used to address the nanotubes are indicated by yellow squares.

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3. Pertaining to claim 1, <u>Rueckes</u> teaches an assembly including a substrate and a conductive trace disposed on the substrate, wherein the trace includes nanotube segments that contact other nanotube segments to define a plurality of conductive pathways along the trace.

- 4. Pertaining to claim 2, <u>Rueckes</u> teaches the assembly of claim 1 wherein the nanotube segments include single walled carbon nanotubes.
- 5. Pertaining to claim 4, <u>Rueckes</u> teaches the assembly of claim 1 wherein the nanotube segments have different lengths (see the explanation of figure 2D on page 95 where Rueckes discloses various minimum bistable device sizes).
- 6. Pertaining to claim 5, <u>Rueckes</u> teaches the assembly of claim 1 wherein the nanotube segments include segments having a length shorter than the length of the article (see the explanation above in the rejection of claim 4).
- 7. Pertaining to claim 6, <u>Rueckes</u> teaches an assembly including a substrate and a conductive trace disposed on the substrate, wherein the trace includes an electrical network of nanotubes in contact with other nanotubes to define a plurality of conductive pathways along the trace.
- 8. Pertaining to claim 7, <u>Rueckes</u> teaches the assembly of claim 6 wherein the nanotubes include single walled carbon nanotubes.

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9. Pertaining to claim 9, <u>Rueckes</u> teaches the assembly of claim 6 wherein the nanotubes

have different lengths.

10. Pertaining to claim 10, <u>Rueckes</u> teaches the assembly of claim 6 wherein the nanotubes

include nanotubes having a length shorter than the length of the trace.

11. Pertaining to claim 11, <u>Rueckes</u> teaches an assembly including a substrate and a

conductive trace of predefined shape, the conductive trace being over the substrate, the

conductive trace including a plurality of nanotubes in electrical contact to form a plurality of

conductive paths along the extent of the trace.

12. Pertaining to claim 12, <u>Rueckes</u> teaches an assembly including a substrate, at least one

metal electrode, and a conductive trace of predefined shape, the conductive trace being over the

substrate, the conductive trace including a plurality of nanotubes in electrical contact to form a

plurality of conductive paths along the extent of the trace, and the metal electrode being over at

least a portion of the conductive trace, the metal electrode being formed by a metalization step.

13. Pertaining to claim 13, Rueckes teaches a wafer substrate structure having a non-woven

fabric of nanotubes covering a major surface of the wafer substrate and wherein the nanotubes of

the fabric are arranged in accordance with inherent self-assembly traits of the nanotubes (see

FIG. 1B).

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14. Pertaining to claim 14, <u>Rueckes</u> teaches a wafer substrate structure having a non-woven fabric of nanotubes covering a major surface of the wafer substrate and wherein the fabric is substantially a monolayer of nanotubes.

15. Pertaining to claim 15, <u>Rueckes</u> teaches a wafer substrate structure having a non-woven fabric of nanotubes covering a major surface of the wafer substrate and wherein the fabric has a controlled density of nanotubes.

Claim Rejections - 35 USC § 103

- 16. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 17. Claims 3 and 8 are rejected under 35 U.S.C. 103(a) as being unpatentable over Rueckes et al., "Carbon Nanotube-Based Nonvolatile Random Access Memory for Molecular Computing", SCIENCE Magazine, July 7, 2000, vol. 289, pp 94-97, as applied to claims 1, 2, 4-7 and 9-15 above, and further in view of Lieber et al., U.S. Patent 6,743,408 B2.
- Rueckes fails to teach the assembly of claims 1 and 6 wherein the nanotubes include multi-walled carbon nanotubes. <u>Lieber</u> teaches wherein the nanotubes include multi-walled carbon nanotubes. In view of <u>Lieber</u>, it would have been obvious to one of ordinary skill in the art to incorporate the multi-walled carbon nanotubes of <u>Lieber</u> into the <u>Rueckes</u> semiconductor device because they may be used as memory storage devices (column 7, lines 27-28).

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Conclusion

- 19. Any inquiry concerning this communication or earlier communications from the examiner should be directed to W. David Coleman whose telephone number is 571-272-1856. The examiner can normally be reached on Monday-Friday 9:00 AM 5:30 PM.
- 20. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Olik Chaudhuri can be reached on 571-272-1855. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.
- 21. Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

W. David Coleman Primary Examiner Art Unit 2823